

7. MEASUREMENT OF INTENSITIES

Let E_{meas} represent the *total* integrated intensity measured in a diffraction experiment, with E_0 the contribution from Bragg scattering and E_1 that from (one-phonon) TDS. Then,

$$E_{\text{meas}} = E_0 + E_1 = E_0(1 + \alpha), \quad (7.4.2.1)$$

where α is the ratio E_1/E_0 and is known as the ‘TDS correction factor’. α can be evaluated in terms of the properties of the crystal (elastic constants, temperature) and the experimental conditions of measurement. In the following, it is implied that the intensities are measured using a single-crystal diffractometer with incident radiation of a fixed wavelength λ . We shall treat separately the calculation of α for X-rays and for thermal neutrons.

7.4.2.2. TDS correction factor for X-rays (single crystals)

The differential cross section, representing the intensity per unit solid angle for Bragg scattering, is

$$\left(\frac{d\sigma}{d\Omega}\right)^{(0)} = \frac{N(2\pi)^3}{V} |F(\mathbf{h})|^2 \delta(\mathbf{H} - 2\pi\mathbf{h}),$$

where N is the number of unit cells, each of volume V , and $F(\mathbf{h})$ is the structure factor. \mathbf{H} is the scattering vector, defined by

$$\mathbf{H} = \mathbf{k} - \mathbf{k}_0,$$

with \mathbf{k} and \mathbf{k}_0 the wavevectors of the scattered and incident beams, respectively. (The scattering is elastic, so $k = k_0 = 2\pi/\lambda$, where λ is the wavelength.) $2\pi\mathbf{h}$ is the reciprocal-lattice vector and the delta function shows that the scattered intensity is restricted to the reciprocal-lattice points.

The integrated Bragg intensity is given by

$$\begin{aligned} E_0 &= \int \int \left(\frac{d\sigma}{d\Omega}\right)^{(0)} d\Omega dt \\ &= N \frac{(2\pi)^3}{V} |F(\mathbf{h})|^2 \int \int \delta(\mathbf{H} - 2\pi\mathbf{h}) d\Omega dt, \end{aligned} \quad (7.4.2.2)$$

where the integration is over the solid angle Ω subtended by the detector at the crystal and over the time t spent in scanning the reflection. Using

$$\int \delta(\mathbf{H}) d\mathbf{H} = 1,$$

with $d\mathbf{H} = H d\theta$, equation (7.4.2.2) reduces to the familiar result (James, 1962)

$$E_0 = \frac{N\lambda^3 |F(\mathbf{h})|^2}{V\omega_0 \sin 2\theta}, \quad (7.4.2.3)$$

where ω_0 is the angular velocity of the crystal and 2θ the scattering angle.

The differential cross section for one-phonon scattering by acoustic modes of small wavevector \mathbf{q} is

$$\begin{aligned} \left(\frac{d\sigma}{d\Omega}\right)^{(1)} &= \frac{(2\pi)^3}{V} |F(\mathbf{h})|^2 \\ &\times \sum_{j=1}^3 \frac{\mathbf{H} \cdot \mathbf{e}_j(\mathbf{q})}{m\omega_j^2(\mathbf{q})} E_j(\mathbf{q}) \delta(\mathbf{H} \pm \mathbf{q} - 2\pi\mathbf{h}) \end{aligned} \quad (7.4.2.4)$$

[see Section 4.1.1 of *ITB* (1992)]. Here, $\mathbf{e}_j(\mathbf{q})$ is the polarization vector of the mode ($j\mathbf{q}$), where j is an index for labelling the acoustic branches of the dispersion relations, m is the mass of the unit cell and $E_j(\mathbf{q})$ is the mode energy. The delta function in (7.4.2.4) shows that the scattering from the mode ($j\mathbf{q}$) is confined to the points in reciprocal space displaced by $\pm\mathbf{q}$ from the reciprocal-lattice point at $\mathbf{q} = 0$. The acoustic modes

involved are of small wavenumber, for which the dispersion relation can be written

$$\omega_j(\mathbf{q}) = v_j |\mathbf{q}|, \quad (7.4.2.5)$$

where v_j is the velocity of the elastic wave with polarization vector $\mathbf{e}_j(\mathbf{q})$. Substituting (7.4.2.5) into (7.4.2.4) shows that the intensity from the acoustic modes varies as $1/q^2$, and so peaks strongly at the reciprocal-lattice points to give rise to the TDS error.

Integrating the delta function in (7.4.2.4) gives the integrated one-phonon intensity

$$\begin{aligned} E_1 &= \frac{\lambda^3}{V^2 \omega_0 \sin 2\theta_B} H^2 |F(\mathbf{h})|^2 \\ &\times \sum_q \sum_j \frac{[\mathbf{H} \cdot \mathbf{e}_j(\mathbf{q})]^2}{\rho \omega_j^2(\mathbf{q})} E_j(\mathbf{q}), \end{aligned}$$

with ρ the crystal density. The sum over the wavevectors \mathbf{q} is determined by the range of \mathbf{q} encompassed in the intensity scan. The density of wavevectors is uniform in reciprocal space [see Section 4.1.1 of *ITB* (1992)], and so the sum can be replaced by an integral

$$\sum_q \rightarrow \frac{NV}{(2\pi)^3} \int d\mathbf{q}.$$

Thus, the correction factor (E_1/E_0) is given by

$$\alpha = \frac{1}{8\pi^3} \int J(\mathbf{q}) d\mathbf{q}, \quad (7.4.2.6)$$

where

$$J(\mathbf{q}) = \sum_j \frac{\mathbf{H} \cdot \mathbf{e}_j(\mathbf{q})^2}{\rho \omega_j^2(\mathbf{q})} E_j(\mathbf{q}). \quad (7.4.2.7)$$

The integral in (7.4.2.6) is over the range of measurement, and the summation in (7.4.2.7) is over the three acoustic branches. Only long-wavelength elastic waves, with a linear dispersion relation, equation (7.4.2.5), need be considered.

 7.4.2.2.1. Evaluation of $J(\mathbf{q})$

The frequencies $\omega_j(\mathbf{q})$ and polarization vectors $\mathbf{e}_j(\mathbf{q})$ of the elastic waves in equation (7.4.2.7) can be calculated from the classical theory of Voigt (1910) [see Wooster (1962)]. If $\hat{e}_1, \hat{e}_2, \hat{e}_3$ are the direction cosines of the polarization vector with respect to orthogonal axes x, y, z , then the velocity v_j is determined from the elastic stiffness constants c_{ijkl} by solving the following equations of motion.

$$\begin{aligned} \hat{e}_1(A_{11} - \rho v_j^2) + \hat{e}_2 A_{12} + \hat{e}_3 A_{13} &= 0, \\ \hat{e}_1 A_{12} + \hat{e}_2(A_{22} - \rho v_j^2) + \hat{e}_3 A_{23} &= 0, \\ \hat{e}_1 A_{13} + \hat{e}_2 A_{23} + \hat{e}_3(A_{33} - \rho v_j^2) &= 0. \end{aligned}$$

Here, A_{km} is the km element of a 3×3 symmetric matrix \mathbf{A} ; if $\hat{q}_1, \hat{q}_2, \hat{q}_3$ are the direction cosines of the wavevector \mathbf{q} with reference to x, y, z , the km element is given in terms of the elastic stiffness constants by

$$A_{km} = \sum_{l=1}^3 \sum_{n=1}^3 c_{klmn} \hat{q}_l \hat{q}_n.$$

The four indices $klmn$ can be reduced to two, replacing 11 by 1, 22 by 2, 33 by 3, 23 and 32 by 4, 31 and 13 by 5, and 12 and 21 by 6. The elements of \mathbf{A} are then given explicitly by

7.4. CORRECTION OF SYSTEMATIC ERRORS

$$\begin{aligned}
 A_{11} &= c_{11}\hat{q}_1^2 + c_{66}\hat{q}_2^2 + c_{55}\hat{q}_3^2 + 2c_{56}\hat{q}_2\hat{q}_3 \\
 &\quad + 2c_{15}\hat{q}_3\hat{q}_1 + 2c_{16}\hat{q}_1\hat{q}_2, \\
 A_{22} &= c_{66}\hat{q}_1^2 + c_{22}\hat{q}_2^2 + c_{44}\hat{q}_3^2 + 2c_{24}\hat{q}_2\hat{q}_3 \\
 &\quad + 2c_{46}\hat{q}_3\hat{q}_1 + 2c_{26}\hat{q}_1\hat{q}_2, \\
 A_{33} &= c_{55}\hat{q}_1^2 + c_{44}\hat{q}_2^2 + c_{33}\hat{q}_3^2 + 2c_{34}\hat{q}_2\hat{q}_3 \\
 &\quad + 2c_{35}\hat{q}_3\hat{q}_1 + 2c_{45}\hat{q}_1\hat{q}_2, \\
 A_{12} &= c_{16}\hat{q}_1\hat{q}_2 + c_{26}\hat{q}_2^2 + c_{45}\hat{q}_3^2 + (c_{25} + c_{46})\hat{q}_2\hat{q}_3 \\
 &\quad + (c_{14} + c_{56})\hat{q}_3\hat{q}_1 + (c_{12} + c_{66})\hat{q}_1\hat{q}_2, \\
 A_{13} &= c_{15}\hat{q}_1^2 + c_{46}\hat{q}_2^2 + c_{35}\hat{q}_3^2 + (c_{36} + c_{45})\hat{q}_2\hat{q}_3 \\
 &\quad + (c_{13} + c_{55})\hat{q}_3\hat{q}_1 + (c_{14} + c_{56})\hat{q}_1\hat{q}_2, \\
 A_{23} &= c_{56}\hat{q}_1^2 + c_{24}\hat{q}_2^2 + c_{34}\hat{q}_3^2 + (c_{23} + c_{44})\hat{q}_2\hat{q}_3 \\
 &\quad + (c_{36} + c_{45})\hat{q}_3\hat{q}_1 + (c_{25} + c_{46})\hat{q}_1\hat{q}_2.
 \end{aligned}$$

The setting up of the matrix \mathbf{A} is a fundamental first step in calculating the TDS correction factor. This implies a knowledge of the elastic constants, whose number ranges from three for cubic crystals to twenty one for triclinic crystals. The measurement of elastic stiffness constants is described in Section 4.1.6 of *IT B* (1992).

For each direction of propagation $\hat{\mathbf{q}}$, there are three values of ρv_j^2 ($j = 1, 2, 3$), given by the eigenvalues of \mathbf{A} . The corresponding eigenvectors of \mathbf{A} are the polarization vectors $\mathbf{e}_j(\mathbf{q})$. These polarization vectors are mutually perpendicular, but are not necessarily parallel or perpendicular to the propagation direction.

The function $J(\mathbf{q})$ in equation (7.4.2.7) is related to the inverse matrix \mathbf{A}^{-1} by

$$J(\mathbf{q}) = \frac{k_B T}{q^2} \sum_{m=1}^3 \sum_{n=1}^3 (\mathbf{A}^{-1})_{mn} H_m H_n, \quad (7.4.2.8)$$

where H_1, H_2, H_3 are the x, y, z components of the scattering vector \mathbf{H} , and classical equipartition of energy is assumed [$E_j(\mathbf{q}) = k_B T$]. Thus \mathbf{A}^{-1} determines the anisotropy of the TDS in reciprocal space, arising from the anisotropic elastic properties of the crystal.

Isodiffusion surfaces, giving the locus in reciprocal space for which the intensity $J(\mathbf{q})$ is constant for elastic waves of a given wavelength, were first plotted by Jahn (1942). These surfaces are not spherical even for cubic crystals (unless $c_{11} - c_{12} = c_{44}$), and their shapes vary from one reciprocal-lattice point to another.

7.4.2.2.2. Calculation of α

Inserting (7.4.2.8) into (7.4.2.6) gives the TDS correction factor as

$$\alpha = \sum_{m=1}^3 \sum_{n=1}^3 T_{mn} H_m H_n, \quad (7.4.2.9)$$

where T_{mn} , an element of a 3×3 symmetric matrix \mathbf{T} , is defined by

$$T_{mn} = \frac{k_B T}{8\pi^3} \int \frac{(\mathbf{A}^{-1})_{mn}}{q^2} d\mathbf{q}. \quad (7.4.2.10)$$

Equation (7.4.2.9) can also be written in the matrix form

$$\alpha = \mathbf{H}^T \mathbf{T} \mathbf{H}, \quad (7.4.2.11)$$

with $\mathbf{H}^T = (H_1, H_2, H_3)$ representing the transpose of \mathbf{H} .

The components of \mathbf{H} relate to orthonormal axes, whereas it is more convenient to express them in terms of Miller indices hkl

and the axes of the reciprocal lattice. If \mathbf{S} is the 3×3 matrix that transforms the scattering vector \mathbf{H} from orthonormal axes to reciprocal-lattice axes, then

$$\mathbf{H} = \mathbf{S} \mathbf{h}, \quad (7.4.2.12)$$

where $\mathbf{h}^T = (h, k, l)$. The final expression for α , from (7.4.2.11) and (7.4.2.12), is

$$\alpha = \mathbf{h}^T \mathbf{S}^T \mathbf{T} \mathbf{S} \mathbf{h}. \quad (7.4.2.13)$$

This is the basic formula for the TDS correction factor.

We have assumed that the entire one-phonon TDS under the Bragg peak contributes to the measured integrated intensity, whereas some of it is removed in the background subtraction. This portion can be calculated by taking the range of integration in (7.4.2.10) as that corresponding to the region of reciprocal space covered in the background measurement.

To evaluate \mathbf{T} requires the integration of the function \mathbf{A}^{-1} over the scanned region in reciprocal space (see Fig. 7.4.2.2). Both the function itself and the scanned region are anisotropic about the reciprocal-lattice point, and so the TDS correction is anisotropic too, *i.e.* it depends on the direction of the diffraction vector as well as on $\sin \theta/\lambda$.

Computer programs for calculating the anisotropic TDS correction for crystals of any symmetry have been written by Rouse & Cooper (1969), Stevens (1974), Merisalo & Kurittu (1978), Helmholtz, Braam & Vos (1983), and Sakata, Stevenson & Harada (1983). To simplify the calculation, further approximations can be made, either by removing the anisotropy associated with \mathbf{A}^{-1} or that associated with the scanned region. In the first case, the element T_{mn} is expressed as

$$T_{mn} = \frac{k_B T}{8\pi^3} \langle (\mathbf{A}^{-1})_{mn} \rangle \int \frac{1}{q^2} dq,$$

where the angle brackets indicate the average value over all directions. In the second case,

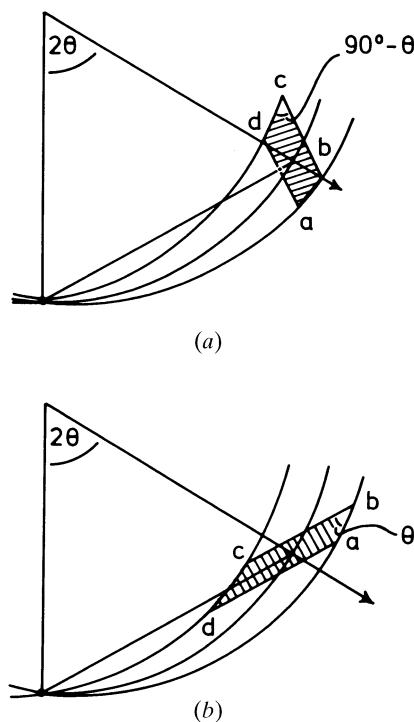


Fig. 7.4.2.2. Diagrams in reciprocal space illustrating the volume $abcd$ swept out for (a) an ω scan, and (b) a $\theta/2\theta$, or $\omega/2\theta$, scan. The dimension of ab is determined by the aperture of the detector and of bc by the rocking angle of the crystal.